



CIE Expert Tutorial on the Application of CIE S 026:2018 CIE System for Metrology of Optical Radiation for ipRGC-Influenced Responses to Light

March 14 – 15, 2019, Eindhoven, the Netherlands

WORKSHOP REGISTRATION – Online Registration

Registration Type	Fee/€
Early rate available until February 7, 2019	
Standard rate from February 8 to March 7, 2019	
No on-site registration permitted	
Early Rate – member of a CIE NC	550.00
Early Rate	650.00
Early Rate – Student	330.00
Standard Rate – member of a CIE NC	650.00
Standard Rate	825.00
Standard Rate – Student	400.00
Tutorial Dinner (deadline for registration March 7)	65.00

Notes:

- 1. Fees will only be accepted by credit card payment via the NSVV PayPal account.
- If the full amount of your Early Registration fee has not been received by February 11, 2019, the Standard registration fee will automatically become effective.
- 3. The full amount of your **Standard Registration fee** must be received by **March 11, 2019**. Payment after that date shall lead to cancellation of your registration.
- 4. There will be no On-site registration.
- 5. If registering as a CIE National Committee Member you will need to provide the 2018 National Committee Publication Discount Code as part of the registration, as proof of your membership.
- 6. When registering as a student proof of attendance in a relevant tertiary education programme shall be provided to the convener, including a letter from your Head of Department. This should be sent to the secretariat at <u>info@nsvv.nl</u>
- 7. Please take note of the additional terms and conditions available <u>online</u>.

Enquiries about the registration process should be sent to the secretariat for this event, <u>info@nsvv.nl</u>